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APPLICANT'S(S') INFORMATION DISCLOSURE STATEMENT		Applicant(s): Ulrich KATSCHER, et al.			
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Initial		Document No.	Date	Name	Class	Subcl	Filing Date
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Examiner: <i>Tiffany A. Tegner</i>	Date Considered: <i>May 8<sup>th</sup> 2007</i>
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